TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (Ultra-High-Speed U-MOSIII)

TPCA8022-H

Switching Regulator Applications **Motor Drive Applications** DC/DC Converter Applications

- Small footprint due to a small and thin package
- High speed switching
- Low drain-source ON-resistance

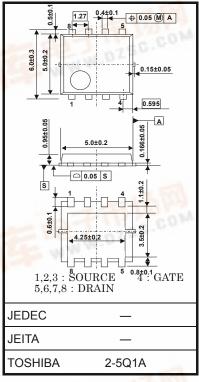
: RDS (ON) = 17 m Ω (typ.) (VGS=10V, ID=11A)

- High forward transfer admittance: $|Y_{fs}| = 46 \text{ S (typ.)}$
- Low leakage current: $IDSS = 10 \mu A (max) (VDS = 100 V)$
- Enhancement mode: $V_{th} = 2.0 \text{ to } 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

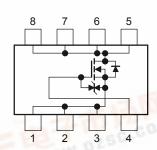
Characte	ristic	Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	100	V	
Drain-gate voltage (R	$GS = 20 \text{ k}\Omega$)	V _{DGR}	100	V	
Gate-source voltage	M.M.	V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	22	А	
Drain current	Pulsed (Note 1)	I_{DP}	66	A	
Drain power dissipation	on (Tc=25°C)	P_{D}	45	W	
Drain power dissipation	on $(t = 10 s)$ (Note 2a)	P_{D}	2.8	W	
Drain power dissipation	on $(t = 10 s)$ (Note 2b)	P_{D}	1.6	W	
Single-pulse avalanche energy (Note 3)		E _{AS}	197	mJ	
Avalanche current	-	I _{AR}	22	Α	
Repetitive avalanche	energy Note 2a) (Note 4)	E _{AR}	3.8	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature	range	T _{stg}	-55 to 150	°C	

Unit: mm



Weight: 0.069 g (typ.)

Circuit Configuration



Note: For Notes 1 to 4, refer to the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.

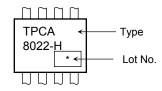


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Thermal Characteristics

Characteristic	Symbol	Max	Unit
Thermal resistance, channel to case (Tc=25°C)	R _{th (ch-c)}	2.78	°C/W
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2a)	R _{th (ch-a)}	44.6	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R _{th (ch-a)}	78.1	°C/W

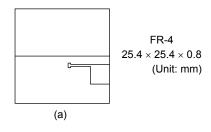
Marking (Note 5)

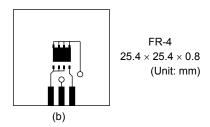


Note 1: The channel temperature should not exceed 150°C during use.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)

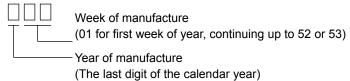




Note 3: $V_{DD} = 50~V$, $T_{ch} = 25^{\circ}C$ (initial), L = 0.5~mH, $R_G = 25~\Omega$, $I_{AR} = 22~A$

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: * Weekly code: (Three digits)





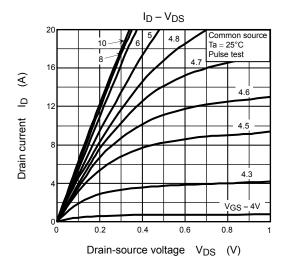
Electrical Characteristics (Ta = 25°C)

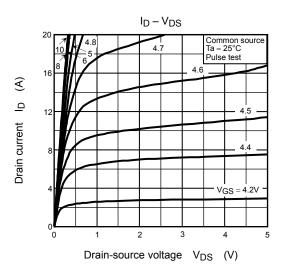
Ch	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	Sate leakage current		$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cutoff curre	ent	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V	_	_	10	μА
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	100	_	_	V
Gate threshold vo	oltage	V _{th}	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	2.0	_	4.0	V
Drain-source ON	-resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 11 A	_	17	26	mΩ
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 11 A	23	46	_	S
Input capacitance	9	C _{iss}			2330	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		110	_	pF
Output capacitance		Coss			420	_	
Gate-Resistance		Rg			1.5	_	Ω
Switching time	Rise time	t _r	ACS 10 A 10	_	4.8	_	- ns
	Turn-on time	t _{on}		_	14	_	
	Fall time	t _f		_	6.7	_	
	Turn-off time	t _{off}	$V_{DD} \simeq 50 \text{ V}$ Duty \leq 1%, $t_W = 10 \mu\text{s}$	_	42	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \approx 80 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 22 \text{ A}$	_	38	_	nC
Gate-source charge 1		Q _{gs1}		_	9.8		
Gate-drain ("Miller") charge		Q _{gd}		_	10	_	
Gate switch charge		Q _{SW}		_	14	_	

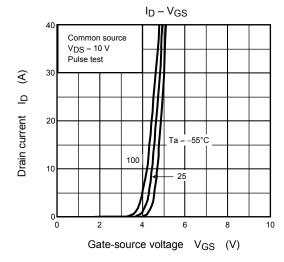
Source-Drain Ratings and Characteristics (Ta = 25°C)

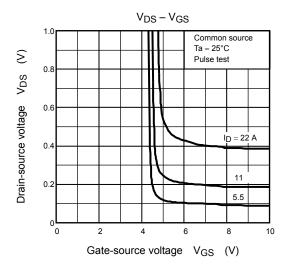
Character	istic	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse	I _{DRP}	_	_	_	66	Α
Forward voltage (diode)		V _{DSF}	I _{DR} = 22 A, V _{GS} = 0 V	_	_	-1.2	V

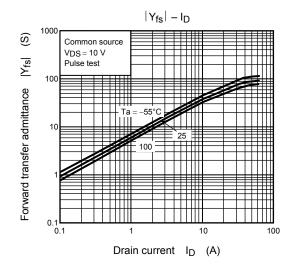
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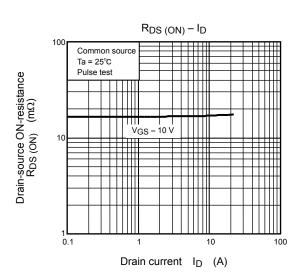


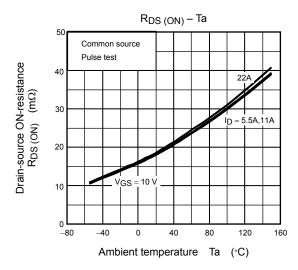


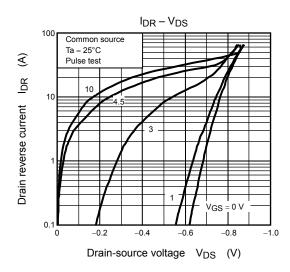


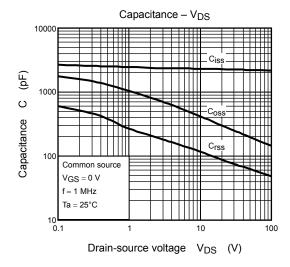


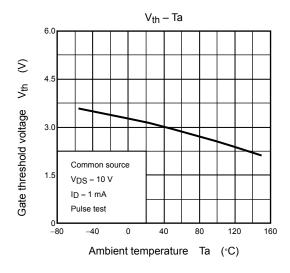


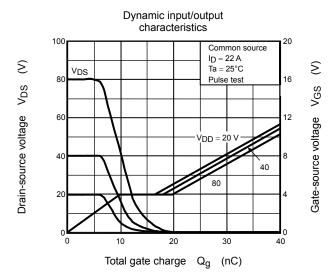






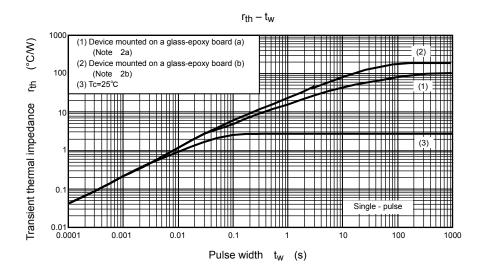


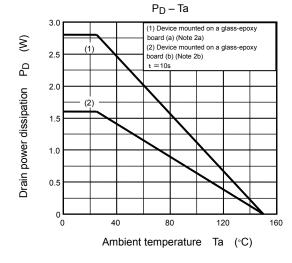


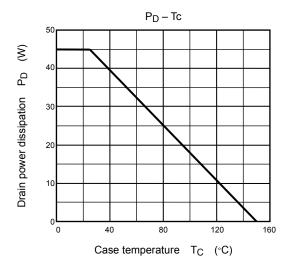


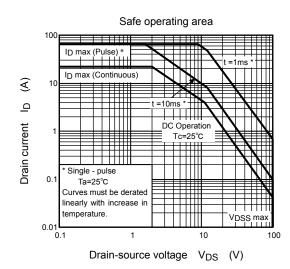
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6

2007-02-09

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